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SNOSAE0K - AUGUST 2004-REVISED MARCH 2013

LM124AQML LM124QML Low Power Quad Operational Amplifiers

Check for Samples: LM124AQML, LM124QML

FEATURES

- Available with Radiation Specification
 - High Dose Rate 100 krad(Si)
 - ELDRS Free 100 krad(Si)
- Internally Frequency Compensated for Unity Gain
- Large DC Voltage Gain 100 dB
- Wide Bandwidth (Unity Gain) 1 MHz (Temperature Compensated)
- Wide Power Supply Range:
 - Single Supply 3V to 32V
 - Or Dual Supplies ±1.5V to ±16V
- Very Low Supply Current Drain (700 μA) Essentially Independent of Supply Voltage
- Low Input Biasing Current 45 nA (Temperature Compensated)
- Low Input Offset Voltage 2 mV and Offset Current: 5 nA
- Input Common-Mode Voltage Range Includes Ground
- Differential Input Voltage Range Equal to the

Power Supply Voltage

Large Output Voltage Swing 0V to V⁺ - 1.5V

DESCRIPTION

The LM124/124A consists of four independent, high gain, internally frequency compensated operational amplifiers which were designed specifically to operate from a single power supply over a wide range of voltages. Operation from split power supplies is also possible and the low power supply current drain is independent of the magnitude of the power supply voltage.

Application areas include transducer amplifiers, DC gain blocks and all the conventional op amp circuits which now can be more easily implemented in single power supply systems. For example, the LM124/124A can be directly operated off of the standard +5Vdc power supply voltage which is used in digital systems and will easily provide the required interface electronics without requiring the additional +15Vdc power supplies.

Unique Characteristics

- In the Linear Mode, the Input Common-Mode Voltage Rrange Includes Ground and the Output Voltage can also Swing to Ground, even though Operated from Only a Single Power Supply Voltage
- The Unity Gain Cross Frequency is Temperature Compensated
- The Input Bias Current is also Temperature Compensated

Advantages

- Eliminates Need for Dual Supplies
- Four Internally Compensated Op Amps in a Single Package
- Allows Directly Sensing near GND and V_{OUT} also Goes to GND
- Compatible with all Forms of Logic
- Power Drain Suitable for Battery Operation

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Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Figure 1. Package Number NAJ0020A

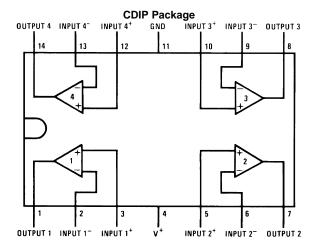


Figure 2. Top View Package Number J0014A

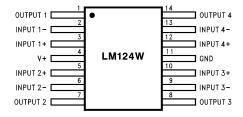
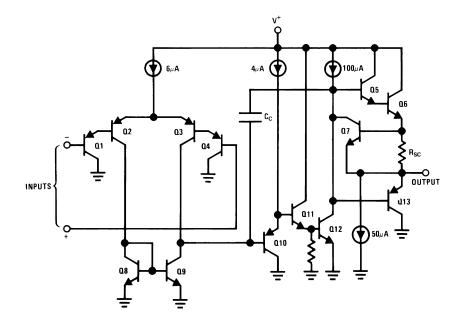


Figure 3. Package Number NAD0014B or NAC0014A



Schematic Diagram

(Each Amplifier)





Absolute Maximum Ratings (1)

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| Supply Voltage, V ⁺ | 32Vdc or ±16Vdc |
|--|---------------------------------|
| Differential Input Voltage | 32Vdc |
| . 3 | |
| Input Voltage | -0.3Vdc to +32Vdc |
| Input Current | |
| (V _{IN} < -0.3Vdc) (2) | 50 mA |
| Power Dissipation (3) | |
| CDIP | 1260mW |
| CLGA | 700mW |
| LCCC | 1350mW |
| CLGA | 700mW |
| Output Short-Circuit to GND | |
| (One Amplifier) (4) | |
| $V^+ \le 15 \text{Vdc}$ and $T_A = 25^{\circ}\text{C}$ | Continuous |
| Operating Temperature Range | -55°C ≤ T _A ≤ +125°C |
| Maximum Junction Temperature | 150°C |
| Storage Temperature Range | -65°C ≤ T _A ≤ +150°C |
| Lead Temperature (Soldering, 10 seconds) | 260°C |
| Thermal Resistance ThetaJA | |
| CDIP (Still Air) | 103°C/W |
| (500LF/Min Air flow) | 51°C/W |
| CLGA (Still Air) | 176°C/W |
| (500LF/Min Air flow) | 116°C/W |
| LCCC (Still Air) | 91°C/W |
| (500LF/Min Air flow) | 66°C/W |
| CLGA (Still Air) | 176°C/W |
| (500LF/Min Air flow) | 116°C/W |
| ThetaJC | |
| CDIP | 19°C/W |
| CLGA | 18°C/W |
| LCCC | 24°C/W |
| CLGA | 18°C/W |
| Package Weight (Typical) | 19 500 |
| CDIP | 2200mg |
| CLGA | 460mg |
| LCCC | 470mg |
| CLGA | 410mg |
| ESD Tolerance ⁽⁵⁾ | 250V |
| | 200 v |

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. For ensured specifications and test conditions, see the Electrical Characteristics. The ensured specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (2) This input current will only exist when the voltage at any of the input leads is driven negative. It is due to the collector-base junction of the input PNP transistors becoming forward biased and thereby acting as input diode clamps. In addition to this diode action, there is also lateral NPN parasitic transistor action on the IC chip. This transistor action can cause the output voltages of the op amps to go to the V+ voltage level (or to ground for a large overdrive) for the time duration that an input is driven negative. This is not destructive and normal output states will re-establish when the input voltage, which was negative, again returns to a value greater than -0.3V_{DC} (at 25°C).
- (3) The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{Jmax} (maximum junction temperature), ThetaJ_A (package junction to ambient thermal resistance), and T_A (ambient temperature). The maximum allowable power dissipation at any temperature is P_{Dmax} = (T_{Jmax} - T_A)/ThetaJ_A or the number given in the Absolute Maximum Ratings, whichever is lower.
- (4) Short circuits from the output to V+ can cause excessive heating and eventual destruction. When considering short circuits to ground, the maximum output current is approximately 40mA independent of the magnitude of V+. At values of supply voltage in excess of +15V_{DC}, continuous short-circuits can exceed the power dissipation ratings and cause eventual destruction. Destructive dissipation can result from simultaneous shorts on all amplifiers.
- 5) Human body model, 1.5 kΩ in series with 100 pF.



Quality Conformance Inspection

MIL-STD-883, Method 5005 - Group A

| Subgroup | Description | Temp (°C) |
|----------|---------------------|------------|
| 1 | Static tests at | +25 |
| 2 | Static tests at | +125 |
| 3 | Static tests at | -55 |
| 4 | Dynamic tests at | +25 |
| 5 | Dynamic tests at | +125 |
| 6 | Dynamic tests at | -55 |
| 7 | Functional tests at | +25 |
| 8A | Functional tests at | +125 |
| 8B | Functional tests at | -55 |
| 9 | Switching tests at | +25 |
| 10 | Switching tests at | +125 |
| 11 | Switching tests at | -55 |



LM124/883 Electrical Characteristics SMD: 77043 DC Parameters

(The following conditions apply to all the following parameters, unless otherwise specified.)

All voltages referenced to device ground.

| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|---------------------|---|---|------------|------|------|------|----------------|
| | | V+ = 5V | | | 1.2 | mA | 1, 2, 3 |
| I _{CC} | Power Supply Current | V+ = 30V | | | 3.0 | mA | 1 |
| | | V+ = 30 V | | | 4.0 | mA | 2, 3 |
| | | $V+ = 15V$, $V_{OUT} = 200mV$, $+V_{IN} = 0mV$, $-V_{IN} = +65mV$ | | 12 | | uA | 1 |
| I _{SINK} | Output Sink Current | $V+ = 15V, V_{OUT} = 2V,$ | | 10 | | mA | 1 |
| | | $+V_{IN} = 0mV, -V_{IN} = +65mV$ | | 5 | | mA | 2, 3 |
| I | Output Source Current | $V+ = 15V, V_{OUT} = 2V,$ | | | -20 | mA | 1 |
| I _{SOURCE} | Output Source Current | $+V_{IN} = 0mV, -V_{IN} = -65mV$ | | | -10 | mA | 2, 3 |
| I _{OS} | Short Circuit Current | $V+ = 5V$, $V_{OUT} = 0V$ | | -60 | | mA | 1 |
| | | V+ = 30V, V _{CM} = 0V | | -5 | 5 | mV | 1 |
| | | v+ = 30 v, v _{CM} = 0 v | | -7 | 7 | mV | 2, 3 |
| | | V+ = 30V, V _{CM} = 28V | | -5 | 5 | mV | 1 |
| V_{IO} | Input Offset Voltage | v+ = 30 v, v _{CM} = 20 v | | -7 | 7 | mV | 2, 3 |
| | | V+ = 5V, V _{CM} = 0V | | -5 | 5 | mV | 1 |
| | | V+ = 5V, VCM = 0V | | -7 | 7 | mV | 2, 3 |
| | | $V+ = 30V, V_{CM} = 28.5V$ | | -5 | 5 | mV | 1 |
| CMRR | Common Mode Rejection Ratio | $V+ = 30V$, $V_{IN} = 0V$ to $28.5V$ | (1) | 70 | | dB | 1 |
| .1 | Input Pigg Current | V+ = 5V, V _{CM} = 0V | (2) | -150 | 10 | nA | 1 |
| +l _{IB} | Input Bias Current | V+ = 5V, VCM = 0V | , , | -300 | 10 | nA | 2, 3 |
| ı | Input Offset Current | V+ = 5V, V _{CM} = 0V | | -30 | 30 | nA | 1 |
| I _{IO} | input Onset Current | V+ = 5V, V _{CM} = 0V | | -100 | 100 | nA | 2, 3 |
| PSRR | Power Supply Rejection Ratio | $V+ = 5V \text{ to } 30V, V_{CM} = 0V$ | | 65 | | dB | 1 |
| W | Common Mode Voltage | V. 20V | (3) | | 28.5 | V | 1 |
| V_{CM} | Range | V+ = 30V | (1) | | 28 | V | 2, 3 |
| ۸ | Larra Circal Cair | $V+ = 15V, R_L = 2K \Omega,$ | | 50 | | V/mV | 4 |
| A _{VS} | Large Signal Gain | $V_O = 1V$ to 11V | | 25 | | V/mV | 5, 6 |
| V | Output Valta and Librar | V+ = 30V, $R_L = 2K \Omega$ | | 26 | | V | 4, 5, 6 |
| V _{OH} | Output Voltage High | V+ = 30 V , R _L = 10 K $Ω$ | | 27 | | V | 4, 5, 6 |
| | | V+ = 30 V , R _L = 10 K $Ω$ | | | 40 | mV | 4, 5, 6 |
| M | Output Valta and Laur | V. 00V I 4::A | | | 40 | mV | 4 |
| V_{OL} | Output Voltage Low | $V+ = 30V$, $I_{SINK} = 1uA$ | | | 100 | mV | 5, 6 |
| | | V+ = 5 V , R _L = 10 K $Ω$ | | | 20 | mV | 4, 5, 6 |
| | Channel Separation (Amp to Amp Coupling) | 1KHz, 20KHz | (4) (5) | 80 | | dB | 4 |

⁽¹⁾ The input common-mode voltage of either input signal voltage should not be allowed to go negative by more than 0.3V (at 25°C). The upper end of the common-mode voltage range is V+ −1.5V (at 25°C), but either or both inputs can go to +32V without damage independent of the magnitude of V+.

⁽²⁾ The direction of the input current is out of the IC due to the PNP input stage. This current is essentially constant, independent of the state of the output so no loading change exists on the input lines.

⁽³⁾ Specified by V_{IO} tests.

⁽⁴⁾ Ensured, not tested

⁽⁵⁾ Due to proximity of external components, insure that coupling is not originating via stray capacitance between these external parts. This typically can be detected as this type of capacitance increases at higher frequencies.



LM124A/883 Electrical Characteristics SMD: 77043 DC Parameters

(The following conditions apply to all the following parameters, unless otherwise specified.)

All voltages referenced to device ground.

| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|---------------------|---|---|------------|------|------|------|----------------|
| | | V+ = 5V | | | 1.2 | mA | 1, 2, 3 |
| I _{CC} | Power Supply Current | V. 20V | | | 3.0 | mA | 1 |
| | | V+ = 30V | | | 4.0 | mA | 2, 3 |
| | | $V+ = 15V, V_{OUT} = 200mV, +V_{IN} = 0mV, -V_{IN} = +65mV$ | | 12 | | uA | 1 |
| I _{SINK} | Output Sink Current | V+ = 15V, V _{OUT} = 2V, | | 10 | | mA | 1 |
| | | $+V_{IN} = 0mV, -V_{IN} = +65mV$ | | 5 | | mA | 2, 3 |
| | Outrast Course Course | V+ = 15V, V _{OUT} = 2V, | | | -20 | mA | 1 |
| I _{SOURCE} | Output Source Current | $+V_{IN} = 0mV, -V_{IN} = -65mV$ | | | -10 | mA | 2, 3 |
| Ios | Short Circuit Current | V+ = 5V, V _{OUT} = 0V | | -60 | | mA | 1 |
| | | V: 20V V 0V | | -2 | 2 | mV | 1 |
| | | $V+ = 30V, V_{CM} = 0V$ | | -4 | 4 | mV | 2, 3 |
| M | Innut Offact Valtage | V+ = 30V, V _{CM} = 28.5V | | -2 | 2 | mV | 1 |
| V_{IO} | Input Offset Voltage | V+ = 30V, V _{CM} = 28V | | -4 | 4 | mV | 2, 3 |
| | | V. 5V.V. 0V | | -2 | 2 | mV | 1 |
| | | $V+ = 5V$, $V_{CM} = 0V$ | | -4 | 4 | mV | 2, 3 |
| CMRR | Common Mode Rejection Ratio | $V+ = 30V$, $V_{IN} = 0V$ to $28.5V$ | (1) | 70 | | dB | 1 |
| | Innut Biog Current | V. 5V.V. 0V | (2) | -50 | 10 | nA | 1 |
| ±l _{IB} | Input Bias Current | $V+=5V$, $V_{CM}=0V$ | (=) | -100 | 10 | nA | 2, 3 |
| | Innut Offact Current | -10 | | -10 | 10 | nA | 1 |
| I _{IO} | Input Offset Current | $V+ = 5V$, $V_{CM} = 0V$ | | -30 | 30 | nA | 2, 3 |
| PSRR | Power Supply Rejection Ratio | V+ = 5V to 30V, V _{CM} = 0V | | 65 | | dB | 1 |
| | Common Mode Voltage | | (3) | | 28.5 | V | 1 |
| V_{CM} | Range | V+ = 30V | (1) | | 28 | V | 2, 3 |
| ^ | 1 O'1 O-'- | $V+ = 15V$, $R_L = 2K Ω$, | (4) | 50 | | V/mV | 4 |
| A _{VS} | Large Signal Gain | $V_O = 1V$ to 11V | (4) | 25 | | V/mV | 5, 6 |
| W | Outset Malta as III | V+ = 30 V , R _L = 2 K $Ω$ | | 26 | | V | 4, 5, 6 |
| V_{OH} | Output Voltage High | V+ = 30 V , R _L = 10 K $Ω$ | | 27 | | V | 4, 5, 6 |
| | | V+ = 30 V , R _L = 10 K $Ω$ | | | 40 | mV | 4, 5, 6 |
| M | Output Valtage Law | \\. 20\\ I 4\ | | | 40 | mV | 4 |
| V_{OL} | Output Voltage Low | $V+ = 30V$, $I_{SINK} = 1uA$ | | | 100 | mV | 5, 6 |
| | | V+ = 5 V , R _L = 10 K $Ω$ | | | 20 | mV | 4, 5, 6 |
| | Channel Separation Amp to Amp Coupling | 1KHz, 20KHz | (5) (6) | 80 | | dB | 4 |

⁽¹⁾ The input common-mode voltage of either input signal voltage should not be allowed to go negative by more than 0.3V (at 25°C). The upper end of the common-mode voltage range is V+ -1.5V (at 25°C), but either or both inputs can go to +32V without damage independent of the magnitude of V+.

The direction of the input current is out of the IC due to the PNP input stage. This current is essentially constant, independent of the state of the output so no loading change exists on the input lines.

Specified by V_{IO} tests.
Datalog reading in K=V/mV

⁽⁵⁾ Ensured, not tested

Due to proximity of external components, insure that coupling is not originating via stray capacitance between these external parts. This typically can be detected as this type of capacitance increases at higher frequencies.



LM124A RAD HARD Electrical Characteristics SMD: 5962R99504 DC Parameters (1) (2)

(The following conditions apply to all the following parameters, unless otherwise specified.)

All voltages referenced to device ground.

| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|-----------------------|-------------------------------------|--|-------|------|------|--------|----------------|
| | | V_{CC} + = 30V, V_{CC} - = Gnd, | | -2 | 2 | mV | 1 |
| | | V _{CM} = +15V | | -4 | 4 | mV | 2, 3 |
| | | V_{CC} + = 2V, V_{CC} - = -28V, | | -2 | 2 | mV | 1 |
| ., | Innut Offeet Veltage | V _{CM} = -13V | | -4 | 4 | mV | 2, 3 |
| V _{IO} | Input Offset Voltage | V_{CC} + = 5V, V_{CC} - = Gnd, | | -2 | 2 | mV | 1 |
| | | $V_{CM} = +1.4V$ | | -4 | 4 | mV | 2, 3 |
| | | V_{CC} + = 2.5V, V_{CC} - = -2.5, | | -2 | 2 | mV | 1 |
| | | V _{CM} = -1.1V | | -4 | 4 | mV | 2, 3 |
| | | V _{CC} + = 30V, V _{CC} - = Gnd, | | -10 | 10 | nA | 1, 2 |
| | | V _{CM} = +15V | | -30 | 30 | nA | 3 |
| | | V_{CC} + = 2V, V_{CC} - = -28V, | | -10 | 10 | nA | 1, 2 |
| | Lament Office to Occurrent | $V_{CM} = -13V$ | | -30 | 30 | nA | 3 |
| lio | Input Offset Current | V_{CC} + = 5V, V_{CC} - = Gnd, | | -10 | 10 | nA | 1, 2 |
| | | $V_{CM} = +1.4V$ | | -30 | 30 | nA | 3 |
| | | V_{CC} + = 2.5V, V_{CC} - = -2.5, | | -10 | 10 | nA | 1, 2 |
| | | V _{CM} = -1.1V | | -30 | 30 | nA | 3 |
| | | V _{CC} + = 30V, V _{CC} - = Gnd, | | -50 | +0.1 | nA | 1, 2 |
| | | V _{CM} = +15V | | -100 | +0.1 | nA | 3 |
| | | V _{CC} + = 2V, V _{CC} - = -28V, | (3) | -50 | +0.1 | nA | 1, 2 |
| .1 | Innut Ding Coment | $V_{CM} = -13V$ | | -100 | +0.1 | nA | 3 |
| ±l _{IB} | Input Bias Current | V_{CC} + = 5V, V_{CC} - = Gnd, | | -50 | +0.1 | nA | 1, 2 |
| | | $V_{CM} = +1.4V$ | | -100 | +0.1 | nA | 3 |
| | | V_{CC} + = 2.5V, V_{CC} - = -2.5, | | -50 | +0.1 | nA | 1, 2 |
| | | V _{CM} = -1.1V | | -100 | +0.1 | nA | 3 |
| +PSRR | Power Supply Rejection Ratio | V_{CC} - = Gnd, V_{CM} = +1.4V, 5V $\leq V_{CC} \leq 30V$ | | -100 | 100 | uV/V | 1, 2, 3 |
| CMRR | Common Mode Rejection Ratio | | (4) | 76 | | dB | 1, 2, 3 |
| l _{os} + | Output Short Circiut Current | V_{CC} + = 30V, V_{CC} - = Gnd, V_{O} = 25V | | -70 | | mA | 1, 2,3 |
| | Power Supply Current | Vant = 30V Van = God | | | 3 | mA | 1, 2 |
| lcc | Power Supply Current | V_{CC} + = 30V, V_{CC} - = Gnd | | | 4 | mA | 3 |
| ΔV _{IO} / ΔΤ | Input Offset Voltage Temperature | | | -30 | 30 | uV/°C | 2 |
| | Sensitivity | $-55^{\circ}\text{C} \le \text{T}_{\text{A}} \le +25^{\circ}\text{C}, +\text{V}_{\text{CC}} = 5\text{V}, \\ -\text{V}_{\text{CC}} = 0\text{V}, \text{V}_{\text{CM}} = +1.4\text{V}$ | | -30 | 30 | uV/ °C | 3 |

⁽¹⁾ Pre and post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the Post Radiation Limits Table. These parts may be dose rate sensitive in a space environment and demonstrate enhanced low dose rate effect. Radiation end point limits for the noted parameters are ensured only for the conditions as specified in MIL-STD-883, Method 1019

⁽²⁾ Low dose rate testing has been performed on a wafer-by-wafer basis, per test method 1019 condition D of MIL-STD-883, with no enhanced low dose rate sensitivity (ELDRS) effect.

⁽³⁾ The direction of the input current is out of the IC due to the PNP input stage. This current is essentially constant, independent of the state of the output so no loading change exists on the input lines.

⁽⁴⁾ The input common-mode voltage of either input signal voltage should not be allowed to go negative by more than 0.3V (at 25°C). The upper end of the common-mode voltage range is V+ −1.5V (at 25°C), but either or both inputs can go to +32V without damage independent of the magnitude of V+.

⁽⁵⁾ Calculated parameters



LM124A RAD HARD Electrical Characteristics SMD: 5962R99504 DC Parameters⁽¹⁾ (continued)

(The following conditions apply to all the following parameters, unless otherwise specified.) **All voltages referenced to device ground.**

| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|----------------------|----------------------|---|-------|------|-----|--------|----------------|
| Δ _{ΙΟ} / ΔΤ | Input Offset Current | $+25^{\circ}\text{C} \le \text{T}_{\text{A}} \le +125^{\circ}\text{C},$ $+\text{V}_{\text{CC}} = 5\text{V}, -\text{V}_{\text{CC}} = 0\text{V},$ $\text{V}_{\text{CM}} = +1.4\text{V}$ | (5) | -400 | 400 | pA/° C | 2 |
| | Sensitivity | $-55^{\circ}\text{C} \le \text{T}_{\text{A}} \le +25^{\circ}\text{C}, +\text{V}_{\text{CC}} = 5\text{V}, \\ -\text{V}_{\text{CC}} = 0\text{V}, \text{V}_{\text{CM}} = +1.4\text{V}$ | | -700 | 700 | pA/ °C | 3 |

LM124A RAD HARD SMD: 5962R99504 AC/DC Parameters (1) (2)

(The following conditions apply to all the following parameters, unless otherwise specified.)

All voltages referenced to device ground.

| Symbol | Parameter | Conditions | Notes | Min | Max | UniT | Sub- G roups |
|---------------------|----------------------------------|---|-------|-----|-----|------|-----------------|
| | | V_{CC} + = 30V, V_{CC} - = Gnd, R_L = 10K Ω | | | 35 | mV | 4, 5, 6 |
| V_{OL} | Logical "0" Output Voltage | V_{CC} + = 30V, V_{CC} - = Gnd, I_{OI} = 5mA | | | 1.5 | V | 4, 5, 6 |
| | | V_{CC} + = 4.5V, V_{CC} - = Gnd, I_{OI} = 2uA | | | 0.4 | V | 4, 5, 6 |
| V | Logical "1" Output | V_{CC} + = 30V, V_{CC} - = Gnd, I_{OH} = -10mA | | 27 | | V | 4, 5, 6 |
| V _{OH} | Voltage | V_{CC} + = 4.5V, V_{CC} - = Gnd, I_{OH} = -10mA | | 2.4 | | V | 4, 5, 6 |
| | | V_{CC} + = 30V, V_{CC} - = Gnd, | | 50 | | V/mV | 4 |
| Λ. | Valtana Cain | $1V \le V_O \le 26V$, $R_L = 10K \Omega$ | | 25 | | V/mV | 5, 6 |
| A _{VS} + | Voltage Gain | V_{CC} + = 30V, V_{CC} - = Gnd, | | 50 | | V/mV | 4 |
| | | $5V \le V_O \le 20V$, $R_L = 2K \Omega$ | | 25 | | V/mV | 5, 6 |
| ^ | Value on Onlin | V_{CC} + = 5V, V_{CC} - = Gnd, 1V ≤ V_O ≤ 2.5V, R_L = 10K Ω | | 10 | | V/mV | 4, 5, 6 |
| A _{VS} | Voltage Gain | V_{CC} + = 5V, V_{CC} - = Gnd, 1V ≤ V_O ≤ 2.5V, R_L = 2K Ω | | 10 | | V/mV | 4, 5, 6 |
| / | Maximum Output | V_{CC} + = 30V, V_{CC} - = Gnd, V_{O} = +30V, R_{L} = 10K Ω | | 27 | | V | 4, 5, 6 |
| +V _{OP} | Voltage Swing | V_{CC} + = 30V, V_{CC} - = Gnd, V_{O} = +30V, R_{L} = 2K Ω | | 26 | | V | 4, 5, 6 |
| TR(_{TR}) | Transient Response: Rise Time | V_{CC} + = 30V, V_{CC} - = Gnd | | | 1 | uS | 7, 8A, 8B |
| TR(_{OS}) | Transient Response: Overshoot | V _{CC} + = 30V, V _{CC} - = Gnd | | | 50 | % | 7, 8A, 8B |
| .0 | Slew Rate: Rise | V _{CC} + = 30V, V _{CC} - = Gnd | | 0.1 | | V/uS | 7, 8A, 8B |
| ±S _R | Slew Rate: Fall | V_{CC} + = 30V, V_{CC} - = Gnd | | 0.1 | | V/uS | 7, 8A, 8B |

⁽¹⁾ Pre and post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the Post Radiation Limits Table. These parts may be dose rate sensitive in a space environment and demonstrate enhanced low dose rate effect. Radiation end point limits for the noted parameters are ensured only for the conditions as specified in MIL-STD-883, Method 1019

⁽²⁾ Low dose rate testing has been performed on a wafer-by-wafer basis, per test method 1019 condition D of MIL-STD-883, with no enhanced low dose rate sensitivity (ELDRS) effect.



LM124A RAD HARD SMD: 5962R99504 AC Parameters (1) (2)

(The following conditions apply to all the following parameters, unless otherwise specified.)

 $AC: +V_{CC} = 30V, -V_{CC} = 0V$

| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|------------------|--------------------|--|-------|-----|-----|--------|----------------|
| NI _{BB} | Noise Broadband | $+V_{CC} = 15V, -V_{CC} = -15V,$ BW = 10Hz to 5KHz | | | 15 | uVrm s | 7 |
| NI _{PC} | Noise Popcorn | $+V_{CC}$ = 15V, $-V_{CC}$ = -15V, R _S = 20K Ω, BW = 10Hz to 5KHz | | | 50 | uVpK | 7 |
| | | $+V_{CC} = 30V$, $-V_{CC} = Gnd$, $R_L = 2K \Omega$ | | 80 | | uVrm s | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, A to B | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, A to C | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, A to D | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, B to A | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, B to C | | 80 | | dB | 7 |
| Cs | Channel Separation | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, B to D | (3) | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, C to A | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, C to B | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, Vin = 1V and 16V, C to D | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $V_{IN} = 1V$ and 16V, D to A | | 80 | | dB | 7 |
| | | $R_L = 2K$ Ohms, $V_{IN} = 1V$ and 16V, D to B | | 80 | | dB | 7 |
| | | $R_L = 2K \Omega$, $Vin = 1V$ and 16V, D to C | | 80 | | dB | 7 |

⁽¹⁾ Pre and post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the Post Radiation Limits Table. These parts may be dose rate sensitive in a space environment and demonstrate enhanced low dose rate effect. Radiation end point limits for the noted parameters are ensured only for the conditions as specified in MIL-STD-883, Method 1019

LM124A RAD HARD - DC Drift Values SMD: 5962R99504 (1) (2)

(The following conditions apply to all the following parameters, unless otherwise specified.)

DC: "Delta calculations performed on QMLV devices at group B, subgroup 5 only"

| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|------------------|----------------------|---|-------|------|-----|------|----------------|
| V _{IO} | Input Offset Voltage | V_{CC} + = 30V, V_{CC} - = Gnd, V_{CM} = +15V | | -0.5 | 0.5 | mV | 1 |
| ±I _{IB} | Input Bias Current | V_{CC} + = 30V, V_{CC} - = Gnd, V_{CM} = +15V | | -10 | 10 | nA | 1 |

⁽¹⁾ Pre and post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the Post Radiation Limits Table. These parts may be dose rate sensitive in a space environment and demonstrate enhanced low dose rate effect. Radiation end point limits for the noted parameters are ensured only for the conditions as specified in MIL-STD-883, Method 1019

⁽²⁾ Low dose rate testing has been performed on a wafer-by-wafer basis, per test method 1019 condition D of MIL-STD-883, with no enhanced low dose rate sensitivity (ELDRS) effect.

⁽³⁾ Due to proximity of external components, insure that coupling is not originating via stray capacitance between these external parts. This typically can be detected as this type of capacitance increases at higher frequencies.

⁽²⁾ Low dose rate testing has been performed on a wafer-by-wafer basis, per test method 1019 condition D of MIL-STD-883, with no enhanced low dose rate sensitivity (ELDRS) effect.



LM124A - POST RADIATION LIMITS +25°C SMD: 5962R99504 (1) (2)

(The following conditions apply to all the following parameters, unless otherwise specified.)

All voltages referenced to device ground.

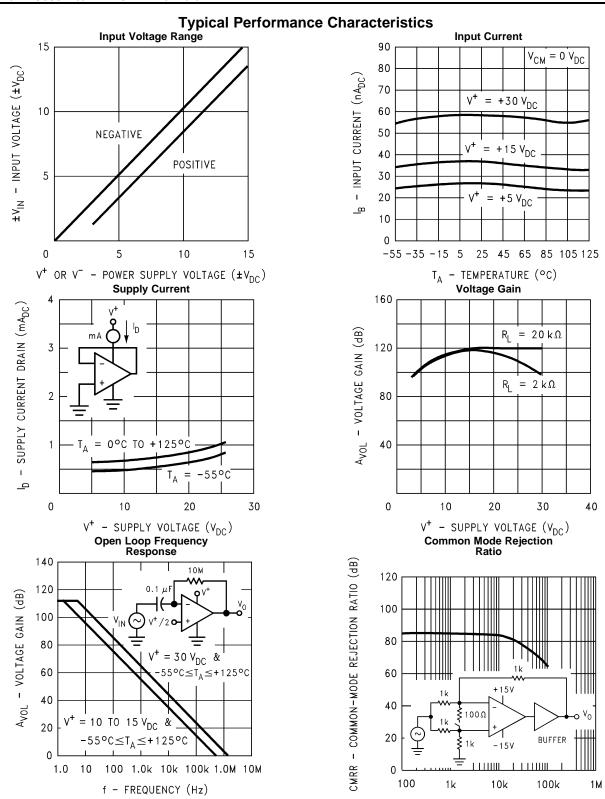
| Symbol | Parameter | Conditions | Notes | Min | Max | Unit | Sub- Groups |
|-------------------|----------------------|--|-------|------|------|------|----------------|
| | | V _{CC} + = 30V, V _{CC} - = Gnd, V _{CM} = +15V | | -2.5 | 2.5 | mV | 1 |
| V | Innut Offact Valtage | V_{CC} + = 2V, V_{CC} - = -28V, V_{CM} = -13V | (1) | -2.5 | 2.5 | mV | 1 |
| V _{IO} | Input Offset Voltage | V_{CC} + = 5V, V_{CC} - = Gnd, V_{CM} = +1.4V | | -2.5 | 2.5 | mV | 1 |
| | | V_{CC} + = 2.5V, V_{CC} - = -2.5, V_{CM} = -1.1V | | -2.5 | 2.5 | mV | 1 |
| | Input Offset Current | V_{CC} + = 30V, V_{CC} - = Gnd, V_{CM} = +15V | | -15 | 15 | nA | 1 |
| I _{IO} | | V _{CC} + = 2V, V _{CC} - = -28V, V _{CM} = -13V | (1) | -15 | 15 | nA | 1 |
| | | V_{CC} + = 5V, V_{CC} - = Gnd, V_{CM} = +1.4V | | -15 | 15 | nA | 1 |
| | | V_{CC} + = 2.5V, V_{CC} - = -2.5V, V_{CM} = -1.1V | | -15 | 15 | nA | 1 |
| | | V _{CC} + = 30V, V _{CC} - = Gnd, V _{CM} = +15V | | -75 | +0.1 | nA | 1 |
| .1 | Innut Ding Current | V_{CC} + = 2V, V_{CC} - = -28V, V_{CM} = -13V | (1) | -75 | +0.1 | nA | 1 |
| ±l _{IB} | Input Bias Current | V_{CC} + = 5V, V_{CC} - = Gnd, V_{CM} = +1.4V | | -75 | +0.1 | nA | 1 |
| | | V_{CC} + = 2.5V, V_{CC} - = -2.5V, V_{CM} = -1.1V | | -75 | +0.1 | nA | 1 |
| Δ . | Valtage Cain | V_{CC} + = 30V, V_{CC} - = Gnd, 1V ≤ V_O ≤ 26V, R_L = 10K Ω | (1) | 40 | | V/mV | 4 |
| A _{VS} + | Voltage Gain | V_{CC} + = 30V, V_{CC} - = Gnd, 5V \leq V_{O} \leq 20V, R_{L} = 2K Ω | | 40 | | V/mV | 4 |

⁽¹⁾ Pre and post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the Post Radiation Limits Table. These parts may be dose rate sensitive in a space environment and demonstrate enhanced low dose rate effect. Radiation end point limits for the noted parameters are ensured only for the conditions as specified in MIL-STD-883, Method 1019

11

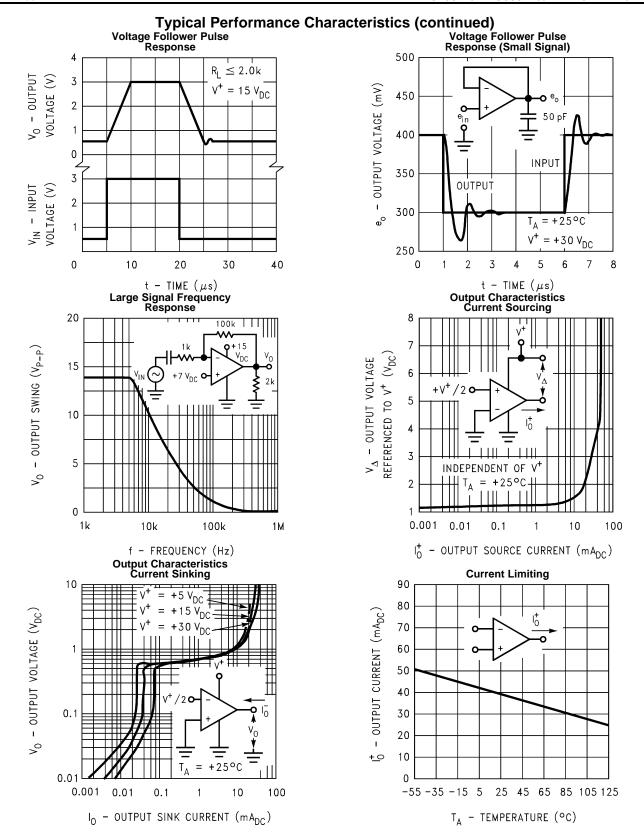
⁽²⁾ Low dose rate testing has been performed on a wafer-by-wafer basis, per test method 1019 condition D of MIL-STD-883, with no enhanced low dose rate sensitivity (ELDRS) effect.





f - FREQUENCY (Hz)







APPLICATION INFORMATION

LM124 Series Operational Amplifiers

The LM124 series are op amps which operate with only a single power supply voltage, have true-differential inputs, and remain in the linear mode with an input common-mode voltage of 0 V_{DC} . These amplifiers operate over a wide range of power supply voltage with little change in performance characteristics. At 25°C amplifier operation is possible down to a minimum supply voltage of 2.3 V_{DC} .

The pinouts of the package have been designed to simplify PC board layouts. Inverting inputs are adjacent to outputs for all of the amplifiers and the outputs have also been placed at the corners of the package (pins 1, 7, 8, and 14).

Precautions should be taken to insure that the power supply for the integrated circuit never becomes reversed in polarity or that the unit is not inadvertently installed backwards in a test socket as an unlimited current surge through the resulting forward diode within the IC could cause fusing of the internal conductors and result in a destroyed unit.

Large differential input voltages can be easily accommodated and, as input differential voltage protection diodes are not needed, no large input currents result from large differential input voltages. The differential input voltage may be larger than V^+ without damaging the device. Protection should be provided to prevent the input voltages from going negative more than $-0.3~V_{DC}$ (at $25^{\circ}C$). An input clamp diode with a resistor to the IC input terminal can be used.

To reduce the power supply drain, the amplifiers have a class A output stage for small signal levels which converts to class B in a large signal mode. This allows the amplifiers to both source and sink large output currents. Therefore both NPN and PNP external current boost transistors can be used to extend the power capability of the basic amplifiers. The output voltage needs to raise approximately 1 diode drop above ground to bias the on-chip vertical PNP transistor for output current sinking applications.

For ac applications, where the load is capacitively coupled to the output of the amplifier, a resistor should be used, from the output of the amplifier to ground to increase the class A bias current and prevent crossover distortion.

Where the load is directly coupled, as in dc applications, there is no crossover distortion.

Capacitive loads which are applied directly to the output of the amplifier reduce the loop stability margin. Values of 50 pF can be accommodated using the worst-case non-inverting unity gain connection. Large closed loop gains or resistive isolation should be used if larger load capacitance must be driven by the amplifier.

The bias network of the LM124 establishes a drain current which is independent of the magnitude of the power supply voltage over the range of from 3 V_{DC} to 30 V_{DC} .

Output short circuits either to ground or to the positive power supply should be of short time duration. Units can be destroyed, not as a result of the short circuit current causing metal fusing, but rather due to the large increase in IC chip dissipation which will cause eventual failure due to excessive junction temperatures. Putting direct short-circuits on more than one amplifier at a time will increase the total IC power dissipation to destructive levels, if not properly protected with external dissipation limiting resistors in series with the output leads of the amplifiers. The larger value of output source current which is available at 25°C provides a larger output current capability at elevated temperatures (see typical performance characteristics) than a standard IC op amp.

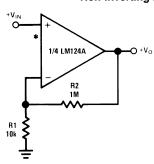
The circuits presented in the section on typical applications emphasize operation on only a single power supply voltage. If complementary power supplies are available, all of the standard op amp circuits can be used. In general, introducing a pseudo-ground (a bias voltage reference of $V^+/2$) will allow operation above and below this value in single power supply systems. Many application circuits are shown which take advantage of the wide input common-mode voltage range which includes ground. In most cases, input biasing is not required and input voltages which range to ground can easily be accommodated.

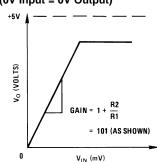


Typical Single-Supply Applications

 $(V^+ = 5.0 V_{DC})$

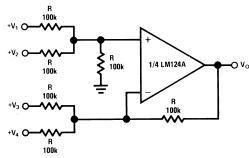
Non-Inverting DC Gain (0V Input = 0V Output)





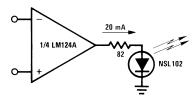
*R not needed due to temperature independent I_{IN}

DC Summing Amplifier ($V_{IN'S} \ge 0 \ V_{DC}$ and $V_O \ge V_{DC}$)

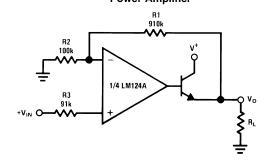


Where: $V_0 = V_1 + V_2 - V_3 - V_4$ $(V_1 + V_2) \ge (V_3 + V_4)$ to keep $V_0 > 0$ V_{DC}

LED Driver

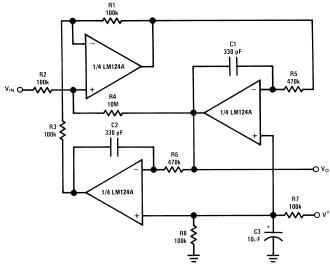


Power Amplifier



 $V_0 = 0 \ V_{DC} \text{ for } V_{IN} = 0 \ V_{DC}$ $A_V = 10$

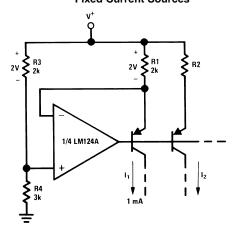
"BI-QUAD" RC Active Bandpass Filter

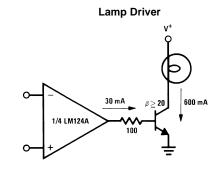


 $f_0 = 1 \text{ kHz}$ Q = 50 $A_V = 100 (40 \text{ dB})$



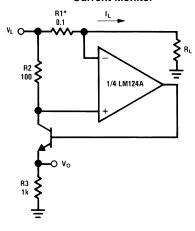
Fixed Current Sources





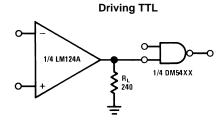
 $I_2 = \left(\frac{R1}{R2}\right)I_1$

Current Monitor

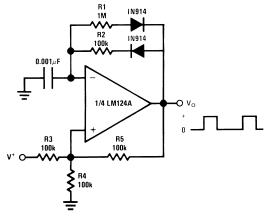




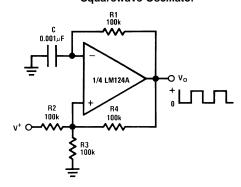
*(Increase R1 for I_L small)



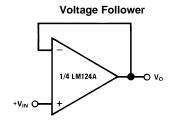
Pulse Generator

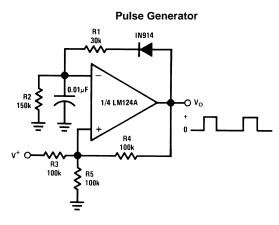


Squarewave Oscillator

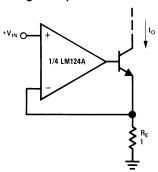






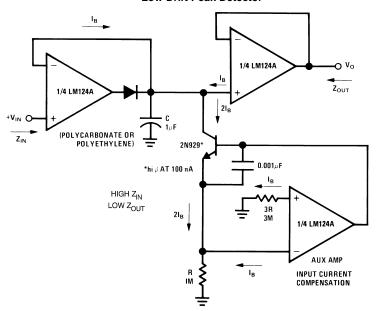


High Compliance Current Sink



 $I_O = 1$ amp/volt V_{IN} (Increase R_E for I_o small)

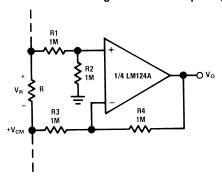
Low Drift Peak Detector





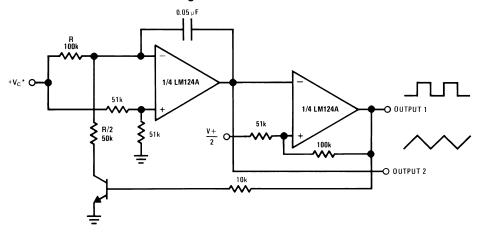
Comparator with Hysteresis

Ground Referencing a Differential Input Signal



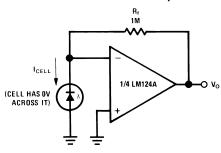
Voltage Controlled Oscillator Circuit

 $V_O = V_R$



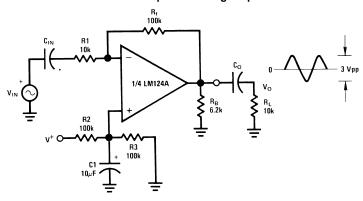
*Wide control voltage range: 0 $V_{DC} \le V_C \le 2 (V^+ -1.5 V_{DC})$

Photo Voltaic-Cell Amplifier



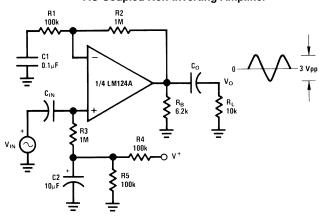


AC Coupled Inverting Amplifier



$$A_V = \frac{R_f}{R_1}$$
 (As shown, $A_V = 10$)

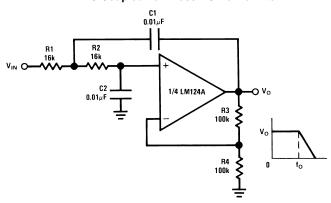
AC Coupled Non-Inverting Amplifier



$$A_V = 1 + \frac{R2}{R1}$$

$$A_V = 11 \text{ (As shown)}$$

DC Coupled Low-Pass RC Active Filter

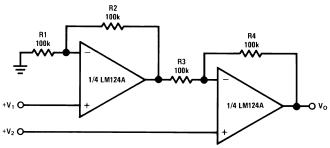


$$f_O = 1 \text{ kHz}$$

 $Q = 1$
 $A_V = 2$



High Input Z, DC Differential Amplifier

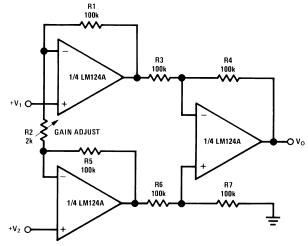


For $\frac{R1}{R2} = \frac{R4}{R3}$ (CMRR depends on this resistor ratio match)

$$V_{O} = 1 + \frac{R4}{R3}(V_{2} - V_{1})$$

As shown: $V_{O} = 2(V_{2} - V_{1})$

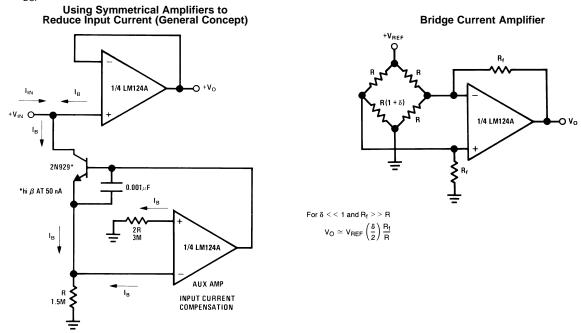
High Input Z Adjustable-Gain DC Instrumentation Amplifier



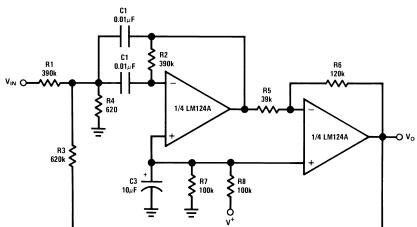
If R1 = R5 & R3 = R4 = R6 = R7 (CMRR depends on match)

$$V_{O} = 1 + \frac{2R1}{R2} (V_{2} - V_{1})$$
 As shown $V_{O} = 101 (V_{2} - V_{1})$





Bandpass Active Filter



 $f_O = 1 \text{ kHz}$ Q = 25



REVISION HISTORY

| Date Released | Revision | Section | Changes |
|---------------|----------|---|--|
| 9/2/04 | А | New Release, Corporate format | 3 MDS data sheets converted into one Corp. data sheet format. MNLM124-X, Rev. 1A2, MNLM124A-X, Rev. 1A3 and MRLM124A-X-RH, Rev. 5A0. MDS data sheets will be archived. |
| 01/27/05 | В | Connection Diagrams, Quality Conformance Inspection Section, and Physical Dimensions drawings | Added E package Connection Diagram. Changed verbiage under Quality Conformance Title, and Updated Revisions for the Marketing Drawings. |
| 04/18/05 | С | Update Absolute Maximum Ratings Section | Corrected typo for Supply Voltage limit From: 32Vdc or +16Vdc TO: 32Vdc or ±16Vdc. Added cerpack, cerdip, LCC package weight. |
| 06/16/06 | D | Features, Ordering Information Table, Rad Hard Electrical Section and Notes | Added Available with Radiation Specification, Low Dose NSID's to table 5962R9950402VCA LM124AJRLQMLV, 5962R9950402VDA LM124AWRLQMLV, 5962R9950402VZA LM124AWGRLQMLV, and reference to Note 10 and 11. Deleted code K NSID's LM124AJLQMLV 5962L9950401VCA, LM124AWGLQMLV 5962L9950401VZA, LM124AWLQMLV 5962L9950401VDA, Note 11 to Rad Hard Electrical Heading. Note 11 to Notes. |
| 10/07/2010 | Е | Data sheet title, Features, Ordering table, Electrical characteristic headings, Rad Hard conditions | Update with current device information and format. Revision D will be Archived |
| 03/26/2013 | K | All Sections | Changed layout of National Data Sheet to TI format |

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PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|---------------------|-------------------------------|------------------|--------------|---|---------|
| 5962R9950401V9A | ACTIVE | DIESALE | Υ | 0 | 30 | RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | | Samples |
| 5962R9950401VCA | ACTIVE | CDIP | J | 14 | 25 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AJRQMLV 5962R9950401VCA Q | Samples |
| 5962R9950401VDA | ACTIVE | CFP | NAD | 14 | 19 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWR (LQMLV Q, QMLV Q) 5962R99504 01VDA ACO 01VDA >T | Samples |
| 5962R9950401VZA | ACTIVE | CFP | NAC | 14 | 42 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWGR QMLV Q 5962R99504 01VZA ACO 01VZA >T | Samples |
| 5962R9950402V9A | ACTIVE | DIESALE | Υ | 0 | 30 | RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | | Samples |
| 5962R9950402VCA | ACTIVE | CDIP | J | 14 | 25 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AJRLQMLV 5962R9950402VCA Q | Samples |
| 5962R9950402VDA | ACTIVE | CFP | NAD | 14 | 19 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWR LQMLV Q 5962R99504 02VDA ACO (02VDA >T, 02VDA A CO) | Samples |
| 5962R9950402VZA | ACTIVE | CFP | NAC | 14 | 42 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWGR LQMLV Q 5962R99504 02VZA ACO 02VZA >T | Samples |
| 7704302XA | ACTIVE | CFP | NAC | 14 | 42 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWG /883 Q 5962-77043 02XA ACO 02XA >T | Samples |
| LM124 MD8 | ACTIVE | DIESALE | Y | 0 | 100 | RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | | Samples |





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| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|------------|--------------|--------------------|------|----------------|------------------------|-------------------------------|------------------|--------------|---|---------|
| LM124 MDE | ACTIVE | DIESALE | Υ | 0 | 30 | RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | | Samples |
| LM124 MDR | ACTIVE | DIESALE | Υ | 0 | 30 | RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | | Samples |
| LM124AE/883 | ACTIVE | LCCC | NAJ | 20 | 50 | RoHS-Exempt & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AE /883 Q 5962-77043 022A ACO 022A >T | Samples |
| LM124AJ/883 | ACTIVE | CDIP | J | 14 | 25 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AJ/883 (5962-7704302CA Q, 5962-7704302C A Q) | Samples |
| LM124AJRLQMLV | ACTIVE | CDIP | J | 14 | 25 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AJRLQMLV 5962R9950402VCA Q | Samples |
| LM124AJRQMLV | ACTIVE | CDIP | J | 14 | 25 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AJRQMLV 5962R9950401VCA Q | Samples |
| LM124AW/883 | ACTIVE | CFP | NAD | 14 | 19 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AW /883 Q ACO /883 Q >T | Samples |
| LM124AWG/883 | ACTIVE | CFP | NAC | 14 | 42 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWG /883 Q 5962-77043 02XA ACO 02XA >T | Samples |
| LM124AWGRLQMLV | ACTIVE | CFP | NAC | 14 | 42 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWGR LQMLV Q 5962R99504 02VZA ACO 02VZA >T | Samples |
| LM124AWGRQMLV | ACTIVE | CFP | NAC | 14 | 42 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWGR QMLV Q 5962R99504 01VZA ACO 01VZA >T | Samples |
| LM124AWRLQMLV | ACTIVE | CFP | NAD | 14 | 19 | Non-RoHS & Green | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWR LQMLV Q 5962R99504 | Samples |



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| Orderable Device | Status | Package Type | | Pins | _ | Eco Plan | Lead finish/ | MSL Peak Temp | Op Temp (°C) | Device Marking | Samples |
|------------------|--------|--------------|---------|------|-----|----------|---------------|---------------------|--------------|--------------------|---------|
| | (1) | | Drawing | | Qty | (2) | Ball material | (3) | | (4/5) | |
| | | | | | | | (6) | | | | |
| | | | | | | | | | | 02VDA ACO | |
| | | | | | | | | | | (02VDA >T, 02VDA A | |
| | | | | | | | | | | CO) | |
| LM124AWRQMLV | ACTIVE | CFP | NAD | 14 | 19 | Non-RoHS | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124AWR | Commiss |
| | | | | | | & Green | | | | (LQMLV Q, QMLV Q) | Samples |
| | | | | | | | | | | 5962R99504 | |
| | | | | | | | | | | 01VDA ACO | |
| | | | | | | | | | | 01VDA >T | |
| LM124J/883 | ACTIVE | CDIP | 1 | 14 | 25 | Non-RoHS | Call TI | Level-1-NA-UNLIM | -55 to 125 | LM124J/883 | |
| LIVI 1240/000 | ACTIVE | CDII | 3 | 14 | 25 | & Green | Call 11 | Level-1-INA-OINLINI | -55 to 125 | (5962-7704301CA Q. | Samples |
| | | | | | | & Green | | | | 5962-7704301CA Q, | |
| | | | | | | | | | | | |
| | | | | | | | | | | AQ) | |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

PACKAGE OPTION ADDENDUM

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF LM124AQML, LM124AQML-SP:

Military: LM124AQML

Space : LM124AQML-SP

NOTE: Qualified Version Definitions:

- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGE MATERIALS INFORMATION

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TUBE



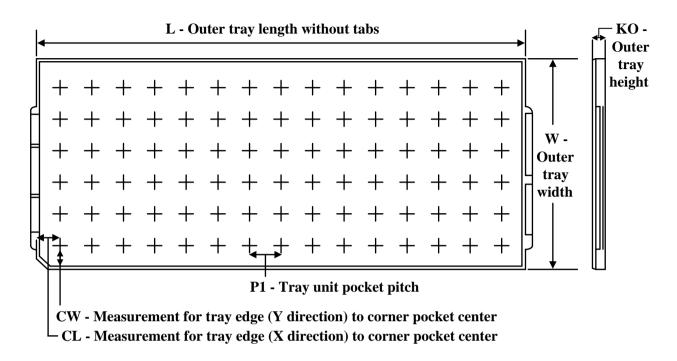
*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|-----------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| 5962R9950401VCA | J | CDIP | 14 | 25 | 506.98 | 15.24 | 13440 | NA |
| 5962R9950401VDA | NAD | CFP | 14 | 19 | 502 | 23 | 9398 | 9.78 |
| 5962R9950402VCA | J | CDIP | 14 | 25 | 506.98 | 15.24 | 13440 | NA |
| 5962R9950402VDA | NAD | CFP | 14 | 19 | 502 | 23 | 9398 | 9.78 |
| LM124AE/883 | NAJ | LCCC | 20 | 50 | 470 | 11 | 3810 | 0 |
| LM124AJ/883 | J | CDIP | 14 | 25 | 506.98 | 15.24 | 13440 | NA |
| LM124AJRLQMLV | J | CDIP | 14 | 25 | 506.98 | 15.24 | 13440 | NA |
| LM124AJRQMLV | J | CDIP | 14 | 25 | 506.98 | 15.24 | 13440 | NA |
| LM124AW/883 | NAD | CFP | 14 | 19 | 502 | 23 | 9398 | 9.78 |
| LM124AWRLQMLV | NAD | CFP | 14 | 19 | 502 | 23 | 9398 | 9.78 |
| LM124AWRQMLV | NAD | CFP | 14 | 19 | 502 | 23 | 9398 | 9.78 |
| LM124J/883 | J | CDIP | 14 | 25 | 506.98 | 15.24 | 13440 | NA |



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TRAY



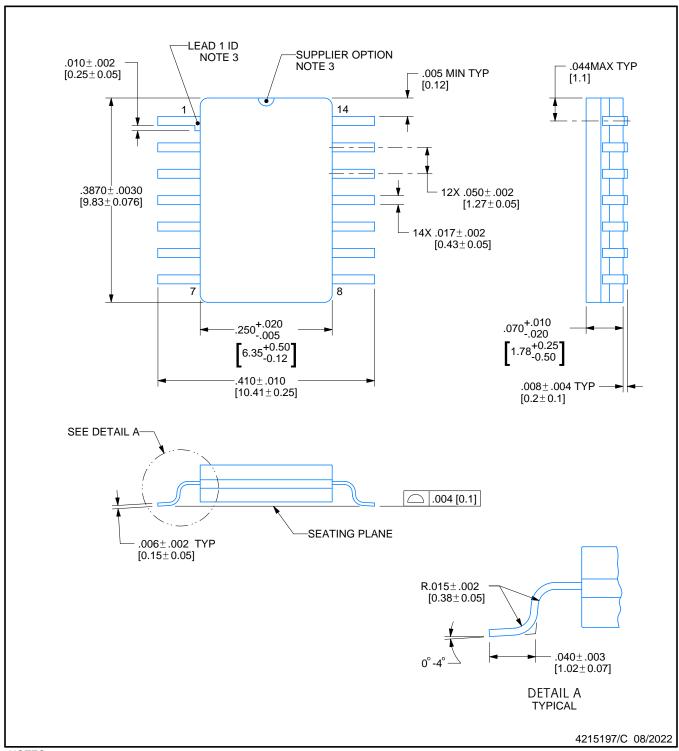
Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | Unit array matrix | Max temperature (°C) | L (mm) | W (mm) | Κ0 (μm) | P1 (mm) | CL (mm) | CW (mm) |
|-----------------|-----------------|-----------------|------|-----|----------------------|----------------------------|--------|-----------|------------|------------|------------|------------|
| 5962R9950401VZA | NAC | CFP | 14 | 42 | 7 X 6 | NA | 101.6 | 101.6 | 8001 | 2.84 | 15.24 | 15.24 |
| 5962R9950402VZA | NAC | CFP | 14 | 42 | 7 X 6 | NA | 101.6 | 101.6 | 8001 | 2.84 | 15.24 | 15.24 |
| 7704302XA | NAC | CFP | 14 | 42 | 7 X 6 | NA | 101.6 | 101.6 | 8001 | 2.84 | 15.24 | 15.24 |
| LM124AWG/883 | NAC | CFP | 14 | 42 | 7 X 6 | NA | 101.6 | 101.6 | 8001 | 2.84 | 15.24 | 15.24 |
| LM124AWGRLQMLV | NAC | CFP | 14 | 42 | 7 X 6 | NA | 101.6 | 101.6 | 8001 | 2.84 | 15.24 | 15.24 |
| LM124AWGRQMLV | NAC | CFP | 14 | 42 | 7 X 6 | NA | 101.6 | 101.6 | 8001 | 2.84 | 15.24 | 15.24 |



CERAMIC FLATPACK

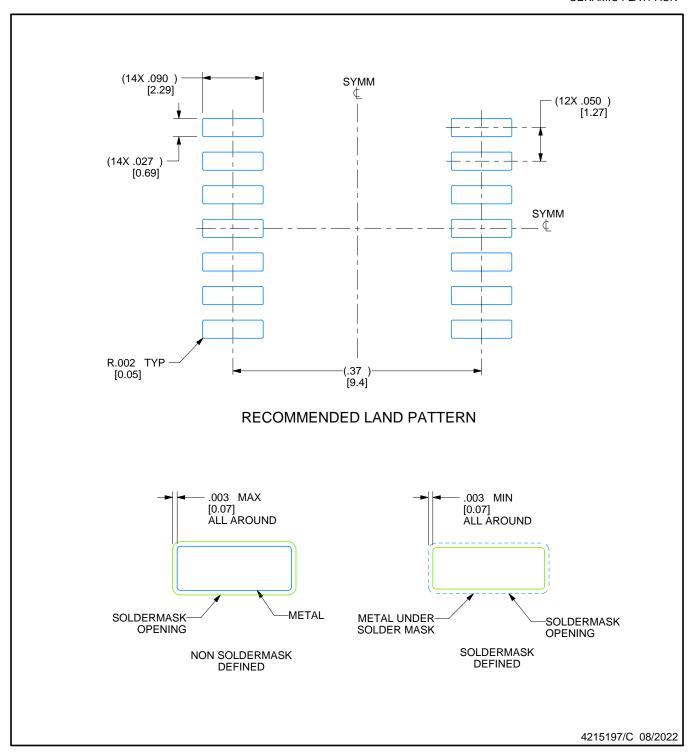


NOTES:

- 1. Controlling dimension is Inch. Values in [] are milimeters. Dimensions in () for reference only.
 2. For solder thickness and composition, see the "Lead Finish Composition/Thickness" link in the packaging section of the Texas Instruments website
- 3. Lead 1 identification shall be:
 - a) A notch or other mark within this area
 - b) A tab on lead 1, either side
- 4. No JEDEC registration as of December 2021

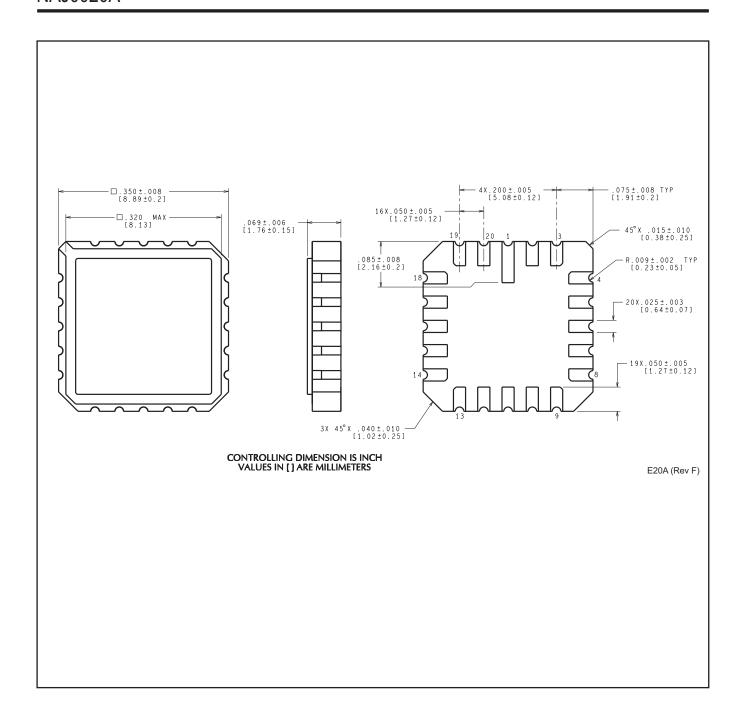


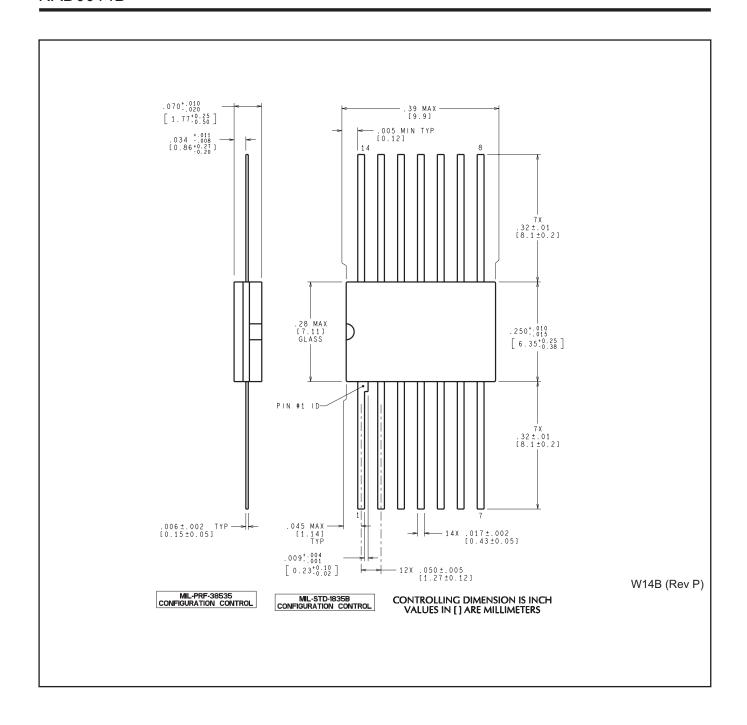
CERAMIC FLATPACK





| | | REVISION | | | |
|-----|--|------------|---------|------------|-------------------------|
| REV | DESCRIPTION | | E.C.N. | DATE | BY/APP'D |
| Α | RELEASE TO DOCUMENT CONTROL | | 2197878 | 12/30/2021 | DAVID CHIN / ANIS FAUZI |
| В | NO CHANGE TO DRAWING; REVISION FOR YODA RELEASE; | | 2198833 | 02/15/2022 | K. SINCERBOX |
| С | .3870± .0030 WAS .39000± .00012; | | 2200916 | 08/08/2022 | D. CHIN / K. SINCERBOX |
| C | 3870± .0030 WAS .39000± .00012: | | 2200916 | 08/08/2022 | D. CHIN / K. SINCERBOX |
| | | SCALE SIZE | | 404=4 | REV PAGE |
| | | A | | 421519 | 97 REV PAGE 4 OF 4 |







CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



NOTES:

- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
 Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
 Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



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